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Istituto Nazionale di Fisica Nucleare

Silicon Undulator Prototype: manufacturing and X-ray Characterization

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Outline

- Why a crystalline undulator?
- Manufacturing techniques
 - The sandblasting method
 - The grooving method
- Conclusions

Classic free electron lasers

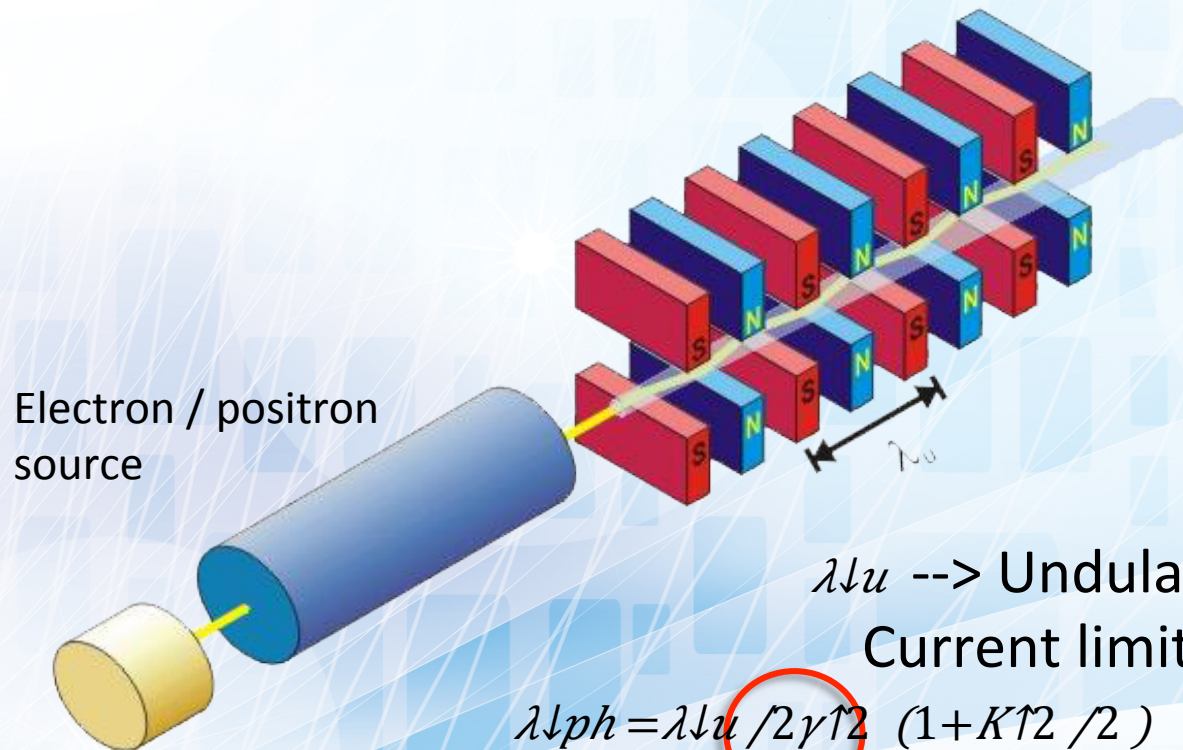
Why a crystalline undulator?

Manufacturing techniques

The sandblasting method

The grooving method

Conclusions



Crystalline undulators

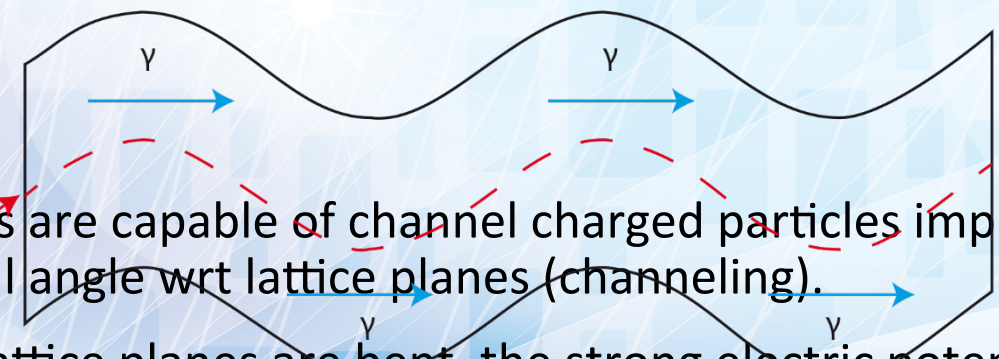
Why a crystalline undulator?

Manufacturing techniques

The sandblasting method

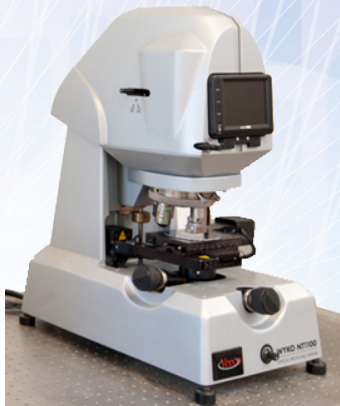
The grooving method

Conclusions

- 
- The diagram illustrates a charged particle beam (red dashed line) entering a crystal lattice (black solid line) that is periodically bent. The beam is shown channeling through the lattice planes, following the curvature of the crystal. Blue arrows labeled γ indicate the direction of the beam's path. A label 'Charged particle beam' points to the red dashed line.
- Crystals are capable of channeling charged particles impinging at small angle wrt lattice planes (channeling).
 - If the lattice planes are bent, the strong electric potential induces channeled particles to follow the crystal curvature.
 - A crystal periodically bent could induce a motion similar to a conventional magnetic undulator, with lower $\lambda \downarrow u$.

Manufacturing techniques

- We decided to manufacture CU made of silicon, because it is a material with a high crystalline order, easy to work.
- Only mechanical techniques have been used, to study the possibilities of such methods. The deformation is self-standing.
- If only mechanical means are used, no contaminating elements are deposited on the CUs.



Why a crystalline undulator?

Manufacturing techniques

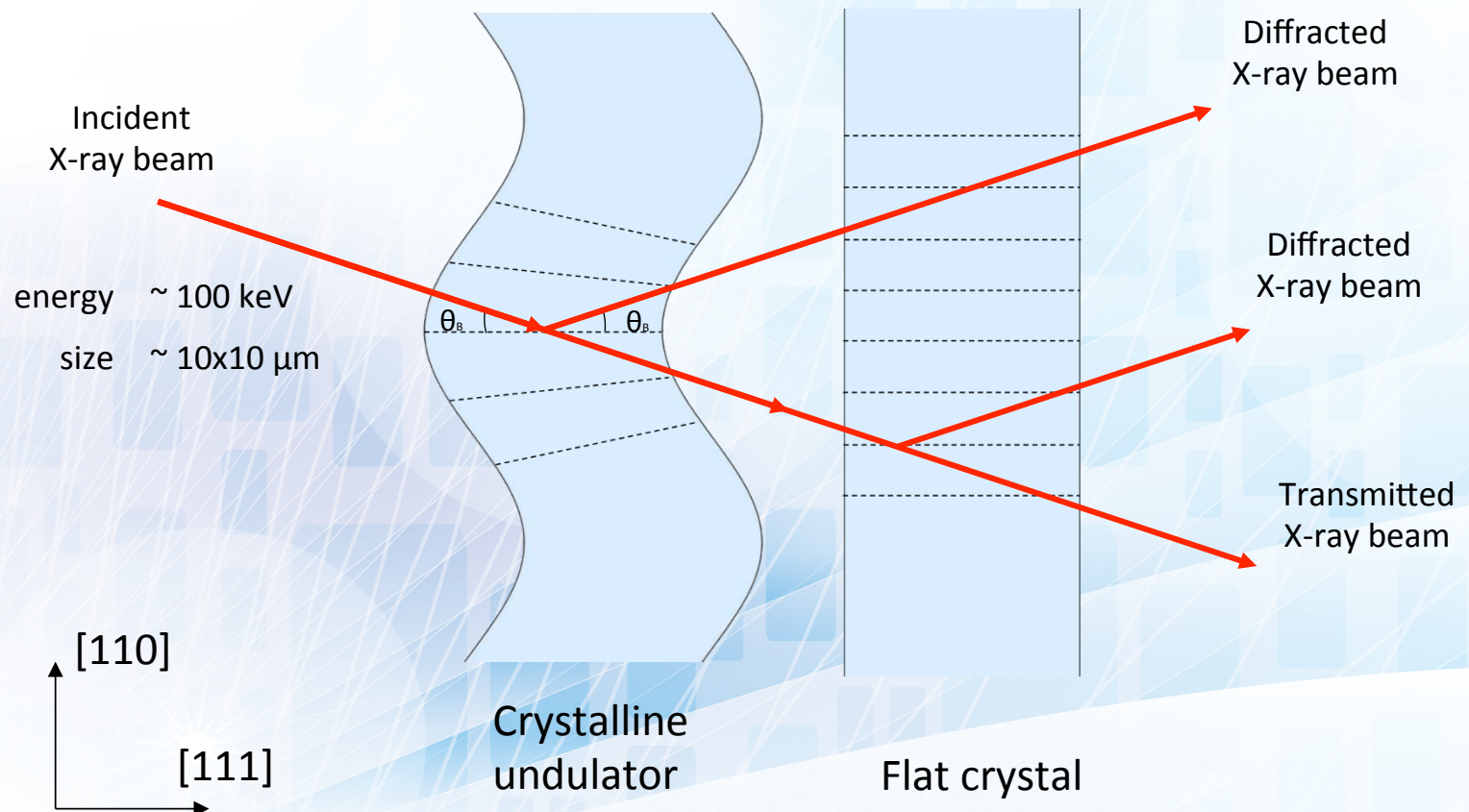
The sandblasting method

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Conclusions

Hard X-ray measurement

Measurements performed at ESRF and ILL (Grenoble, France)



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Sandblasting method

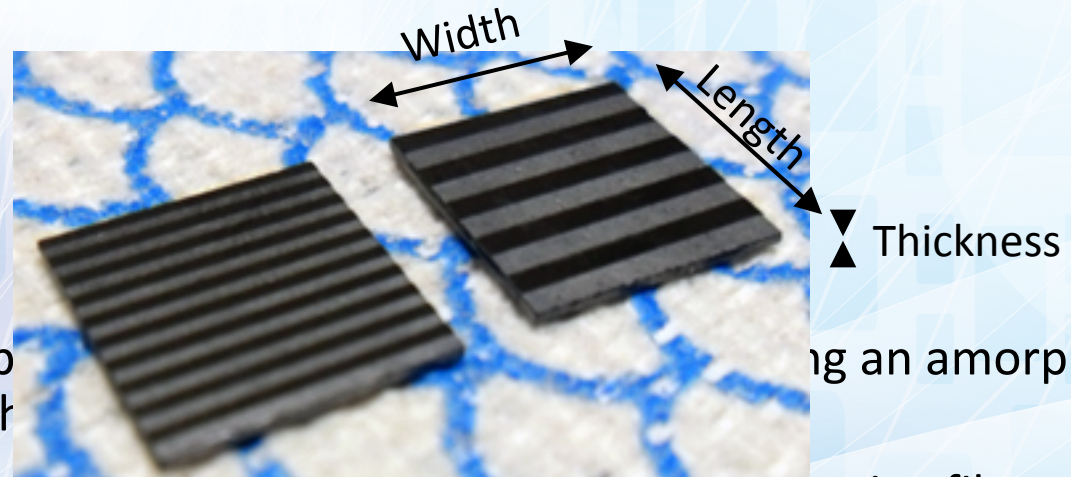
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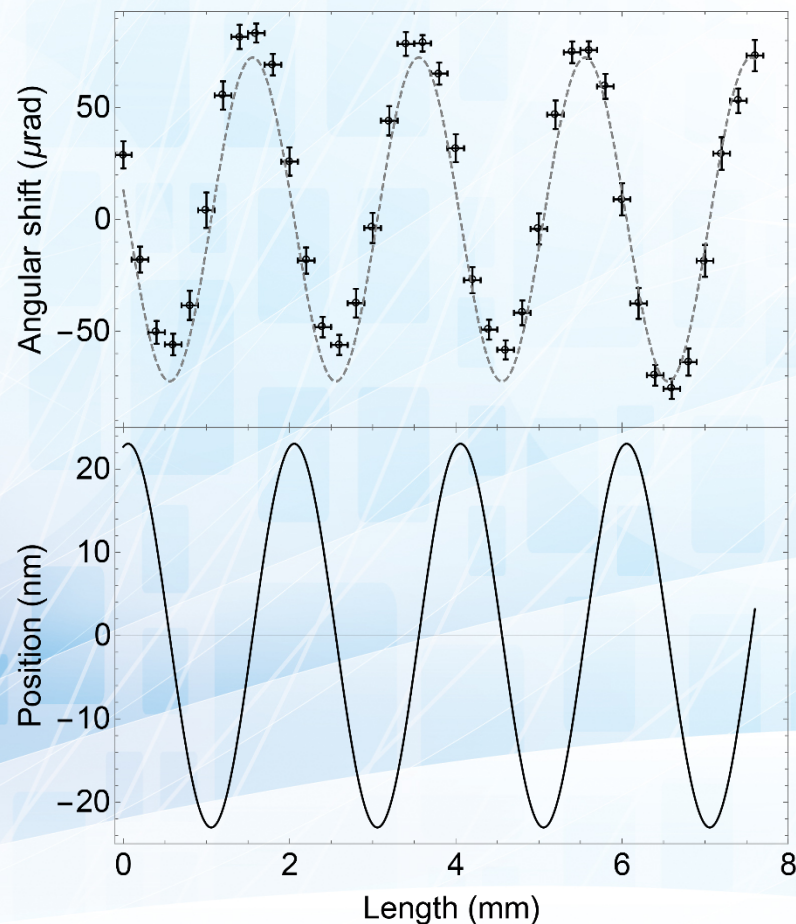
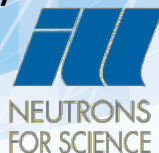


- The sandblasting method creates a layer on the substrate.
- The amorphized layer behaves as a thin compressive film, causing the curvature of the substrate.
- To obtain an undulated deformation, both faces must be patterned, with a phase shift of half a period.

Sandblasting method

| Method | Sandblasting |
|------------------------|---------------|
| Material | Silicon (111) |
| Thickness | 1.0 mm |
| Length | 8.0 mm |
| Width | 10.0 mm |
| Period ($\lambda/4$) | 2.0 mm |
| Number of periods | 4 |
| Amplitude | 23 nm |

Analysed through hard X-rays
at the DIGRA facility, ILL,
Grenoble (France)



Camattari et al. J. Appl. Cryst. 50 (2017) 145-151

Sandblasting method

Why a crystalline undulator?

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Conclusions

Advantages

- No Contaminants
- Adjustable
- Easy and economic
- Fast

Disadvantages

- Crystal damage
- The period (λ/u) is limited to be not smaller than ~ 1 mm

Grooving method

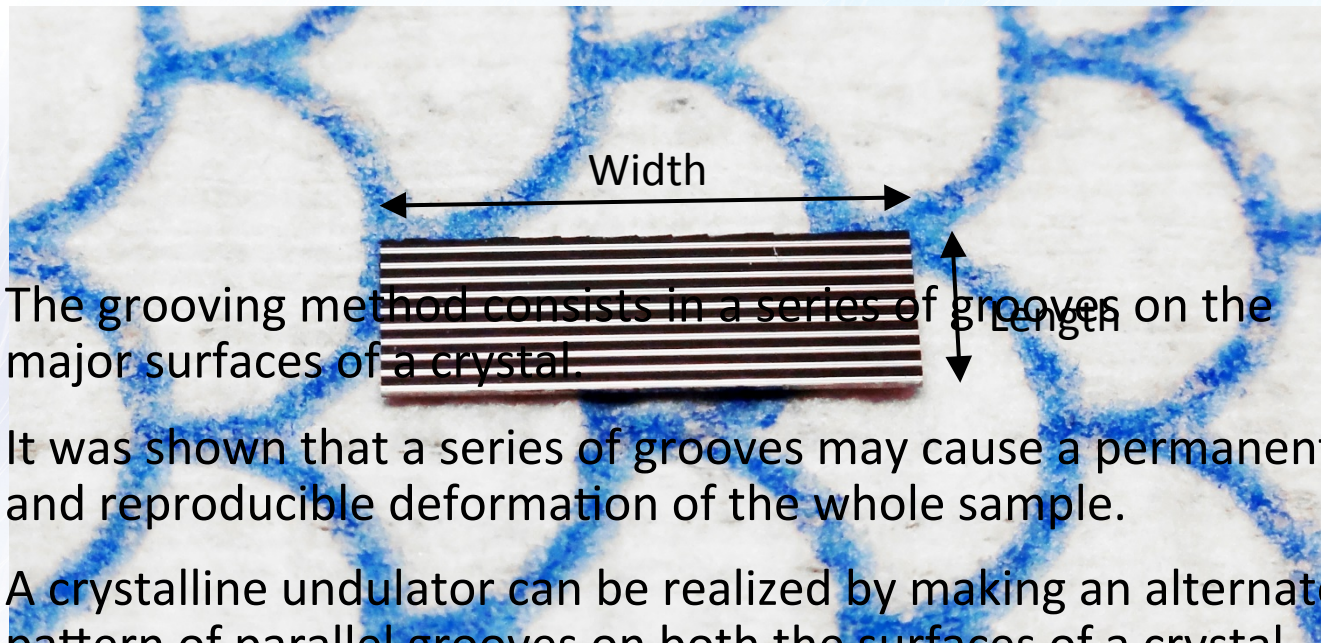
Why a crystalline undulator?

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- The grooving method consists in a series of grooves on the major surfaces of a crystal.
- It was shown that a series of grooves may cause a permanent and reproducible deformation of the whole sample.
- A crystalline undulator can be realized by making an alternate pattern of parallel grooves on both the surfaces of a crystal, with a phase shift of half a period.

Camattari et al Meccanica 48 (2013) 1875-1882

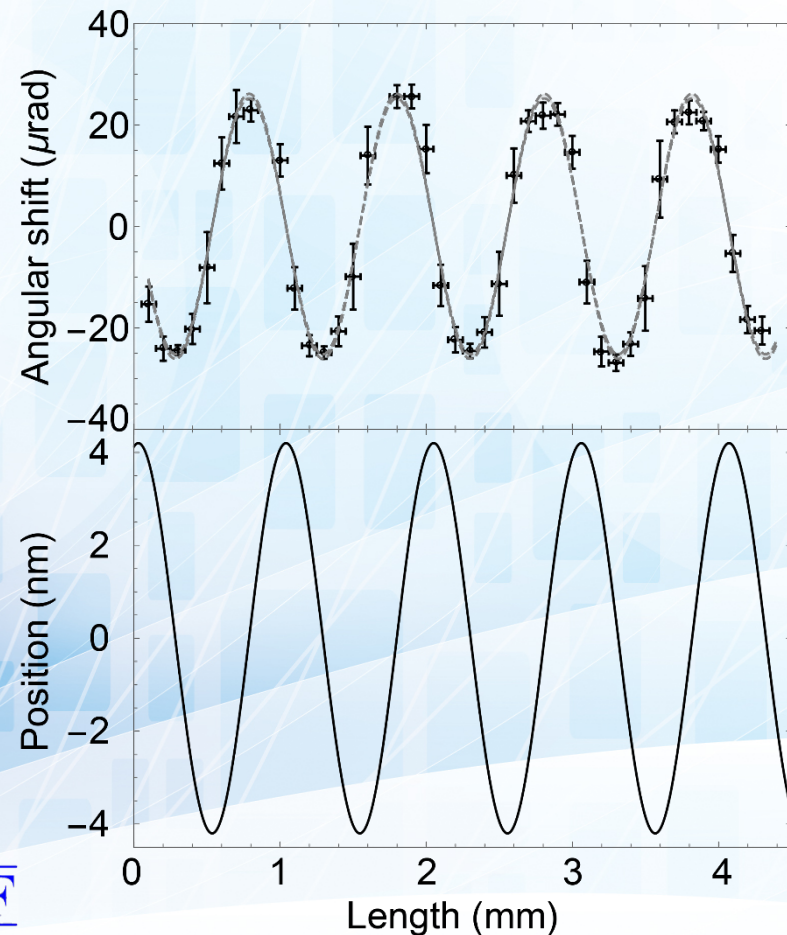
Grooving method

| Method | Grooving |
|------------------------|---------------|
| Material | Silicon (111) |
| Thickness | 0.2 mm |
| Length | 5.0 mm |
| Width | 45.0 mm |
| Period (λ/u) | 1.0 mm |
| Number of periods | 5 |
| Amplitude | 4.1 nm |

Analysed through hard X-rays
at the ID15 facility, ESRF,
Grenoble (France)



Bagli et al. Eur. Phys. J. C 74 (2014) 3114



Grooving method

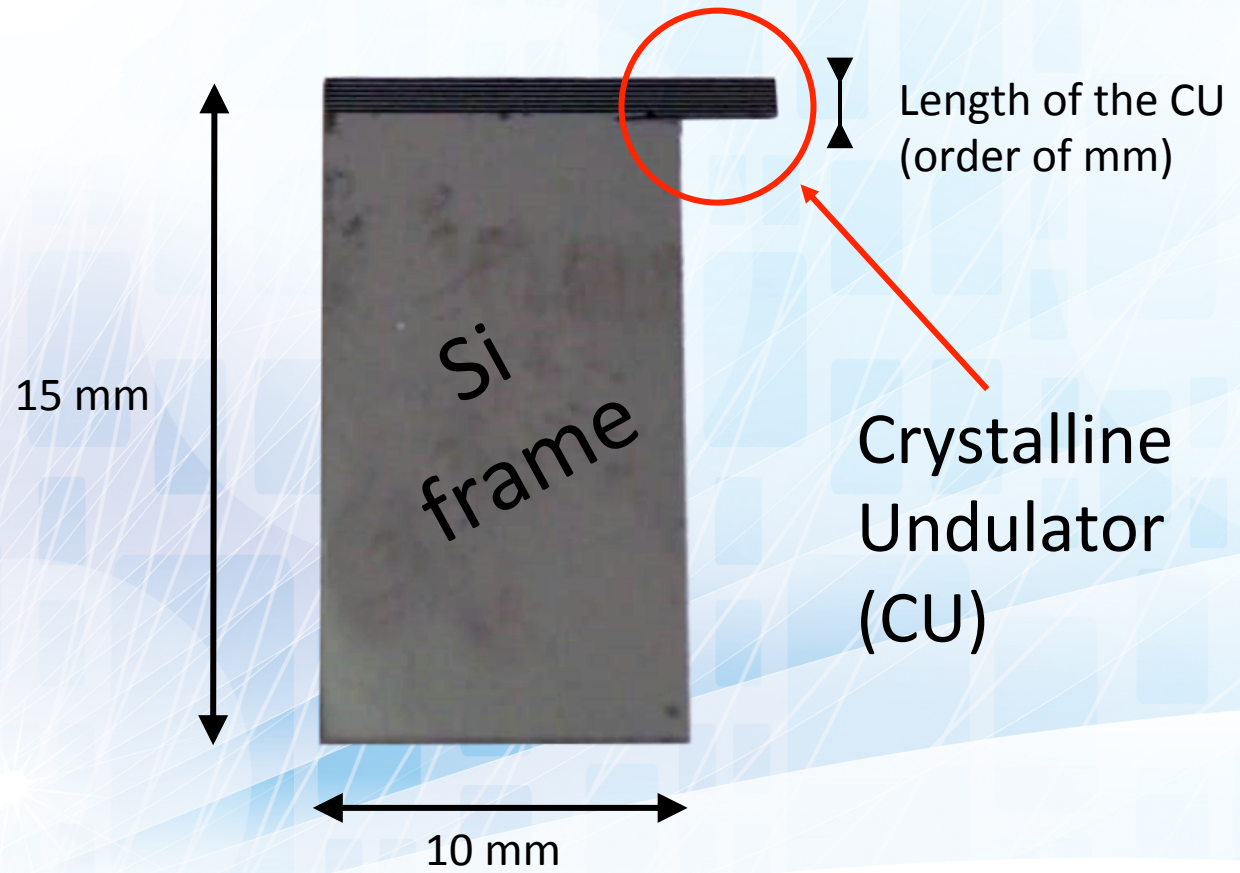
Why a crystalline undulator?

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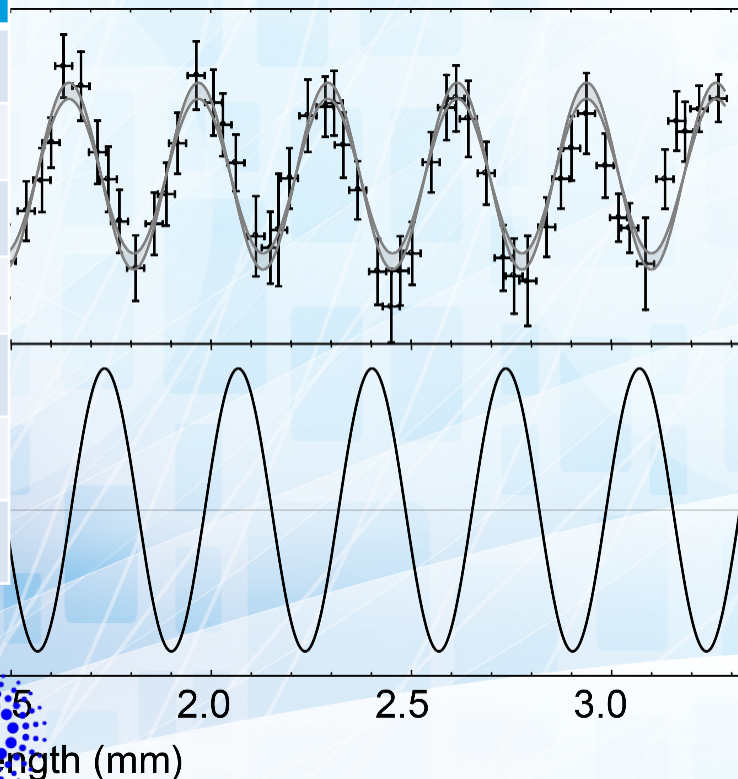
The grooving method

Conclusions



Grooving method

| Method | Grooving |
|---------------------------|---------------|
| Material | Silicon (111) |
| Thickness | 0.2 mm |
| Length | 3.34 mm |
| Width | 10.0 mm |
| Period (λ_{1u}) | 0.334 mm |
| Number of periods | 10 |
| Amplitude | 1.28 nm |

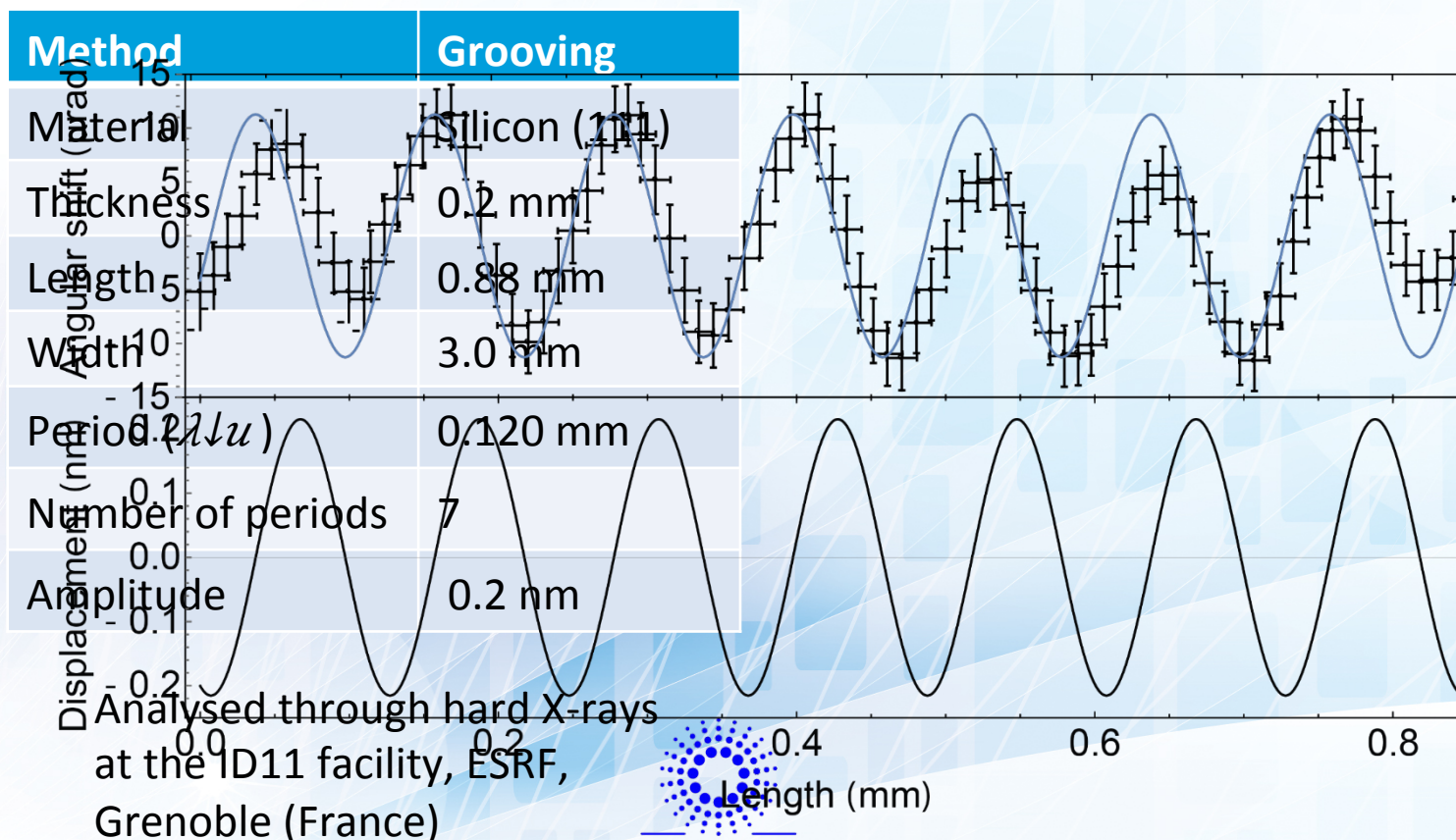


Analysed through hard X-rays
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Grenoble (France)



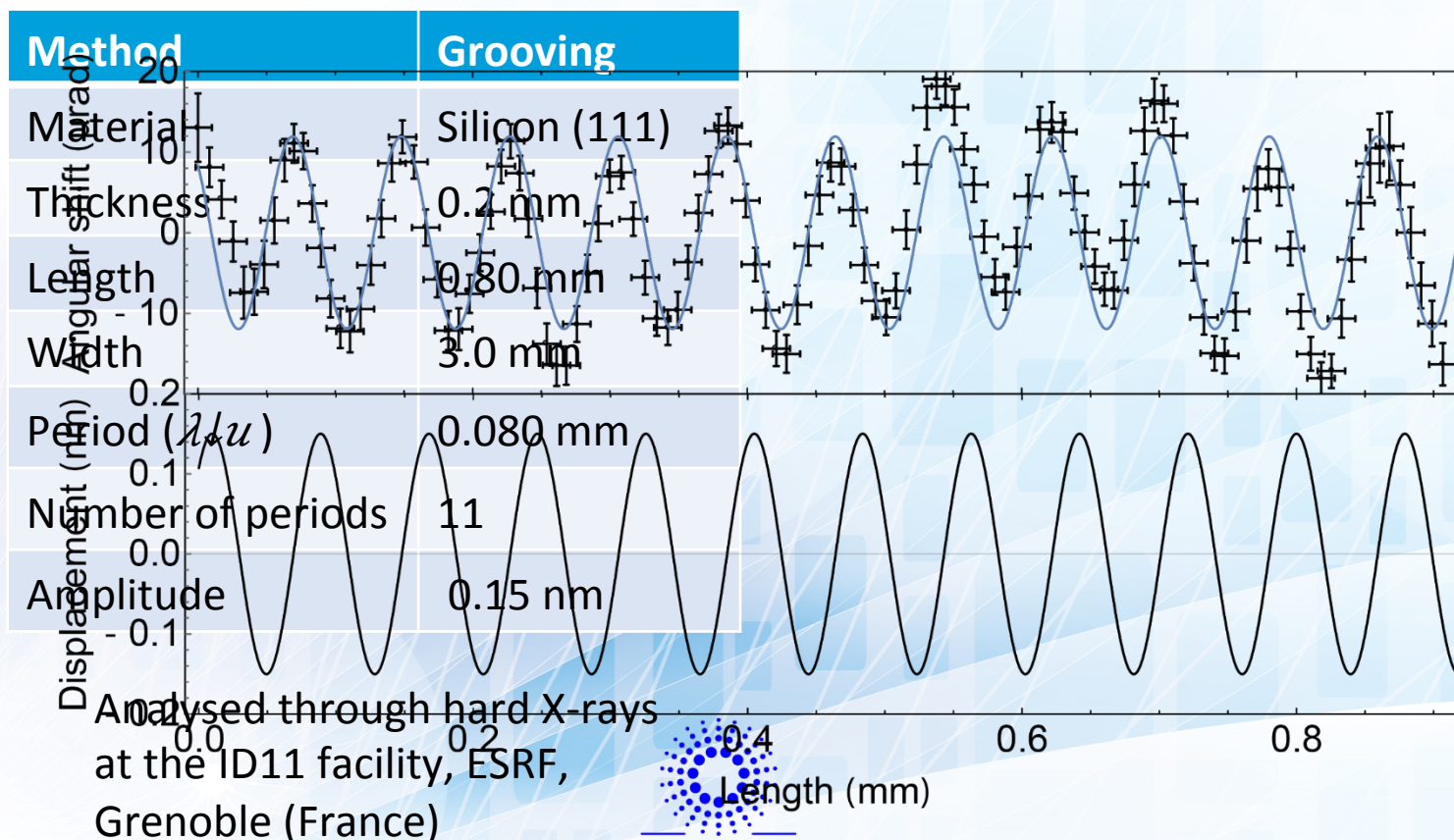
Preliminary results

Grooving method



Preliminary results

Grooving method



Preliminary results



Grooving method

Why a crystalline undulator?

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The grooving method

Conclusions

Advantages

- No Contaminants
- Adjustable
- The period can be as small as the blade width

Disadvantages

- Crystal damage

Method comparison

Why a crystalline undulator?

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Conclusions

| Sandblasting method | | Grooving method | |
|---------------------|---|---------------------|---|
| No contaminants | ↑ | No contaminants | ↑ |
| Adjustable | ↑ | Adjustable | ↑ |
| Higher period | ↓ | Smaller period | ↑ |
| Less crystal damage | ↑ | More crystal damage | ↓ |

Conclusions

- Self-standing undulated crystals have been realized.
- It is possible to decrease the period, but it decreases also the undulating amplitude.
- The smallest period was obtained with the grooving method, namely 80 μm with 0.15 nm of amplitude.
- Test with charged particles are fundamental for evaluating the crystal damage.

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Thank you for your attention

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